

Notice of References Cited	Application/Control No. 10/635,615		Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner Eric E. Silverman, PhD		Art Unit 1615	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0286379	12-2006	Gao, Yong	428/403
*	B	US-2005/0085417	04-2005	Wickstrom et al.	514/012
*	C	US-2004/0248856	12-2004	Lanza et al.	514/124
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Sincai et al in Journal of Magnetism and Magnetic Materials 225 (2001) 235 - 240□□
	V	Sieben et al in Journal of Magnetism and Magnetic Materials 225 (2001) 175 - 179
	W	Kuznetsov et al in Journal of Magnetism and Magnetic Materials 194 (1999) 22 - 30□□
	X	Kwon et al in Korean Journal of Materials Research Vol. 12 (3) 2002 pp215 (English translation prepared by the USPTO)

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.